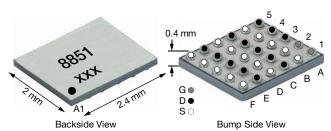
Vishay Siliconix

# P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) Max.	I <sub>D</sub> (A) a, d	Q <sub>g</sub> (Typ.)			
-20	$0.0080$ at $V_{GS} = -4.5 \text{ V}$	-16.7				
	$0.0086$ at $V_{GS} = -3.7 \text{ V}$	-16.1	70 nC			
	0.0110 at V <sub>GS</sub> = -2.5 V	-14.2	70110			
	$0.0185$ at $V_{GS} = -1.8 \text{ V}$	-11				

# Power MICRO FOOT® 2.4 x 2



#### **Ordering Information:**

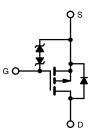
Si8851EDB-T2-E1 (Lead (Pb)-free and halogen-free)

#### **FEATURES**

- TrenchFET® power MOSFET
- Small 2.4 mm x 2 mm outline area
- Low 0.4 mm max. profile
- Typical ESD protection 6000 V HBM
- FREE · Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

#### **APPLICATIONS**

- · Battery switch / load switch
- · Power management
- · For smart phones, tablet PCs, and mobile computing



COMPLIANT

HALOGEN

P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	T <sub>A</sub> = 25 °C, unless	otherwise noted	(h	
PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	-20	V
Gate-Source Voltage		V <sub>GS</sub>	± 8	v
	T <sub>A</sub> = 25 °C		-16.7 <sup>a</sup>	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 70 °C	l-	-13.4 <sup>a</sup>	
Continuous Drain Current (1) = 130 C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	-7.7 b	
	T <sub>A</sub> = 70 °C		-6.2 <sup>b</sup>	A
Pulsed Drain Current (t = 100 μs)		I <sub>DM</sub> -80		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	1	-2.6 <sup>a</sup>	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	-0.55 <sup>b</sup>	
	T <sub>A</sub> = 25 °C		3.1 <sup>a</sup>	
Maximum Dawar Dissipation	T <sub>A</sub> = 70 °C		2 <sup>a</sup>	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	0.66 b	VV
	T <sub>A</sub> = 70 °C		0.43 b	
Operating Junction and Storage Temperature R	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150		
Package Reflow Conditions C	VPR		260	°C
Package Reflow Conditions <sup>c</sup>	IR/Convection		260	

#### Notes

- a. Surface mounted on 1" x 1" FR4 board with full copper, t=5 s. b. Surface mounted on 1" x 1" FR4 board with minimum copper, t=5 s.
- c. Refer to IPC/JEDEC® (J-STD-020), no manual or hand soldering.
- d. Based on  $T_A = 25$  °C.

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	Typical	Maximum	Unit			
Maximum Junction-to-Ambient a, b	t = 5 s	В	30	40	°C/W		
Maximum Junction-to-Ambient c, d	t = 5 s	R <sub>thJA</sub>	145	188	C/VV		

- a. Surface mounted on 1" x 1" FR4 board with full copper.
- b. Maximum under steady state conditions is 85 °C/W.
- Surface mounted on 1" x 1" FR4 board with minimum copper.
- d. Maximum under steady state conditions is 330 °C/W.

# Vishay Siliconix

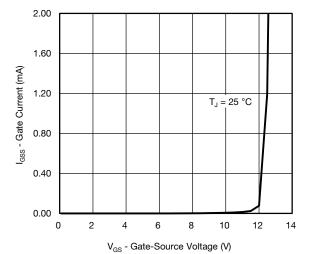
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-20	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$		-	-11	-	mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = -250 μA	-	3	-		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.45	-	-1	V	
0.00	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$	-	-	± 0.5	μΑ	
Gate-Source Leakage		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$	-	-	± 10		
7 0 1 1 1 1 2 1 2		$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	-1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 70 \text{ °C}$	-	-	-10		
On-State Drain Current <sup>a</sup>	in Current <sup>a</sup> $I_{D(on)}$ $V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$		-5	-	-	Α	
		$V_{GS} = -4.5 \text{ V}, I_D = -7 \text{ A}$	-	0.0060	0.0080	†	
Drain Cauras On State Besistance	n	$V_{GS} = -3.7 \text{ V}, I_D = -7 \text{ A}$	-	0.0065	0.0086		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = -2.5 \text{ V}, I_D = -5 \text{ A}$	-	0.0081	0.0110	Ω	
		$V_{GS} = -1.8 \text{ V}, I_D = -3 \text{ A}$	-	0.0130	0.0185	1	
Forward Transconductance a	9 <sub>fs</sub>	$V_{DS} = -10 \text{ V}, I_D = -7 \text{ A}$	-	50	-	S	
Dynamic <sup>b</sup>	<u> </u>		1	1			
Input Capacitance	C <sub>iss</sub>		-	6900	-	pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	640	-		
Reverse Transfer Capacitance	C <sub>rss</sub>		-	715	-		
Total Cata Charge	Qg	$V_{DS} = -10 \text{ V}, V_{GS} = -8 \text{ V}, I_D = -5 \text{ A}$	-	120	180	nC	
Total Gate Charge			-	70	105		
Gate-Source Charge	$Q_{gs}$	$V_{DS}$ = -10 V, $V_{GS}$ = -4.5 V, $I_D$ = -5 A	-	8	-		
Gate-Drain Charge	$Q_{gd}$		-	14	-		
Gate Resistance	$R_g$	V <sub>GS</sub> = -0.1 V, f = 1 MHz	-	2.3	-	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>		-	35	70		
Rise Time	t <sub>r</sub>	$V_{DD}$ = -10 V, $R_L$ = 2 $\Omega$	-	40	80		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ -5 A, $V_{GEN}$ = -4.5 V, $R_g$ = 1 $\Omega$	-	115	230		
Fall Time	t <sub>f</sub>		-	35	70	ns	
Turn-On Delay Time	t <sub>d(on)</sub>		-	15	30		
Rise Time	t <sub>r</sub>	$V_{DD}$ = -10 V, $R_L$ = 2 $\Omega$	-	10	20		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ -5 A, $V_{GEN}=$ -8 V, $R_g=$ 1 $\Omega$	-	110	220		
Fall Time	t <sub>f</sub>		-	25	50		
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>A</sub> = 25 °C	-	-	-2.6	٨	
Pulse Diode Forward Current (t = 100 μs)	I <sub>SM</sub>		-	-	-80	Α	
Body Diode Voltage	$V_{SD}$	$I_S = -5 \text{ A}, V_{GS} = 0 \text{ V}$	-	-0.8	-1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	40	80	ns	
		$I_F = -5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s},$	-	30	60	nC	
Reverse Recovery Fall Time	ta	$T_{\rm J} = 25~{\rm ^{\circ}C}$	-	16	-	- ns	
Reverse Recovery Rise Time	t <sub>b</sub>		-	24	-		

#### Notes

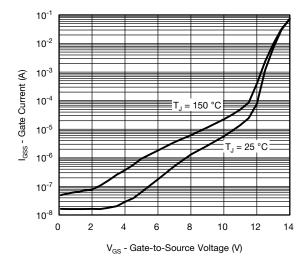
- a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

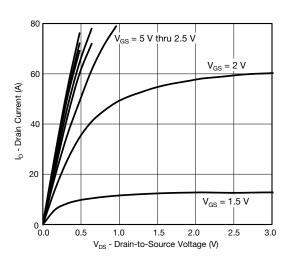




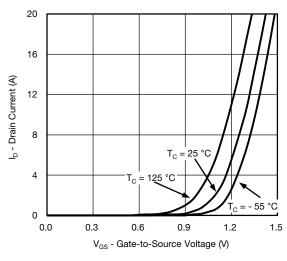
Gate Current vs. Gate-Source Voltage



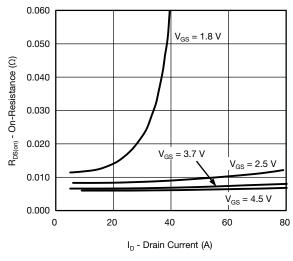
Gate Current vs. Gate-Source Voltage



**Output Characteristics** 

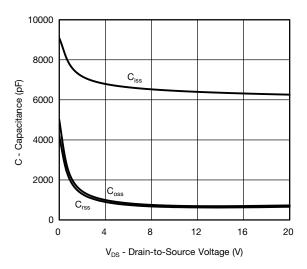


**Transfer Characteristics** 



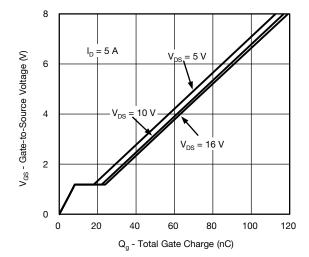


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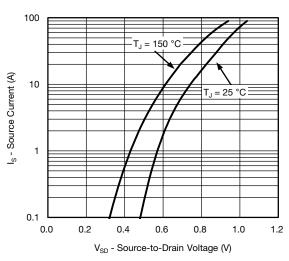


Capacitance

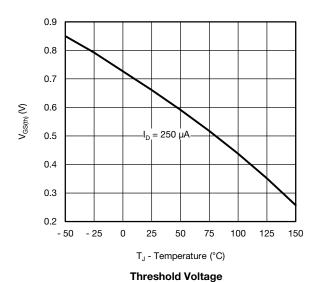




#### **Gate Charge**

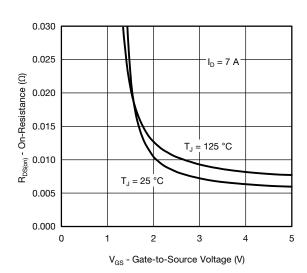


# Source-Drain Diode Forward Voltage

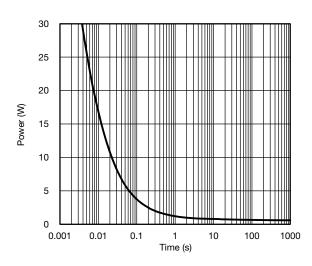


R<sub>DS(on)</sub> - On-Resistance (Normalized) 1.3  $= 2.5 \text{ V}, I_D = 5 \text{ A}$ 1.2 1.1  $V_{GS} = 1.8 \text{ V}, I_{D} = 5 \text{ A}$ 1.0 0.9 0.8 0.7 50 - 25 0 75 100 150 T<sub>1</sub> - Junction Temperature (°C)

#### On-Resistance vs. Junction Temperature

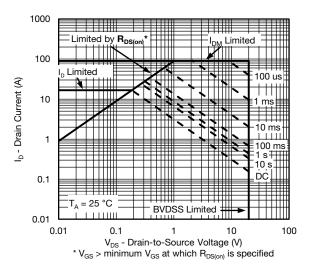


On-Resistance vs. Gate-to-Source Voltage



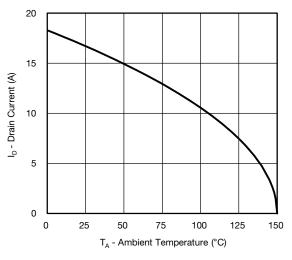
Single Pulse Power, Junction-to-Ambient

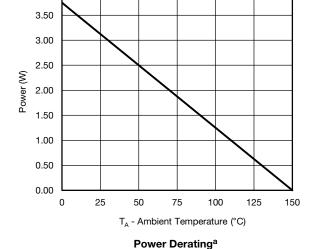




Safe Operating Area, Junction-to-Ambienta

4.00



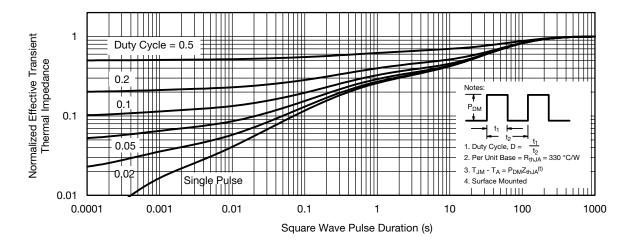


Current Derating <sup>a</sup>

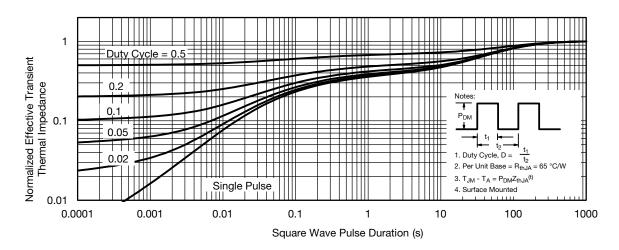
# Note

a. When mounted on 1" x 1" FR4 with full copper and t = 5 s





### Normalized Thermal Transient Impedance, Junction-to-Ambient (on 1" x 1" FR4 Board with minimum Copper)

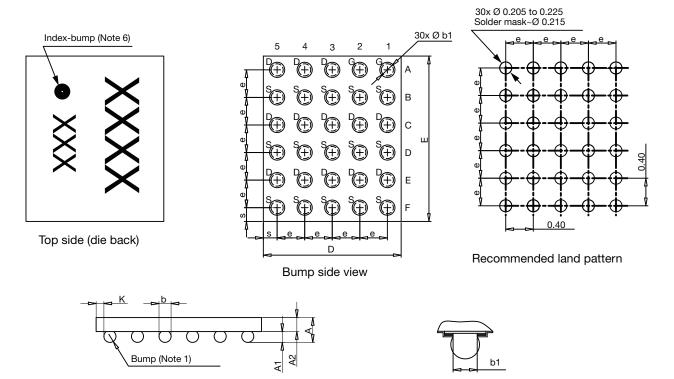


Normalized Thermal Transient Impedance, Junction-to-Ambient (on 1" x 1" FR4 Board with maximum Copper)

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppg?64197">www.vishay.com/ppg?64197</a>.

Vishay Siliconix

# MICRO FOOT®: 30-Bumps (2.4 mm x 2 mm, 0.4 mm Pitch, 0.184 mm Bump Height)



#### Notes

- 1. Bumps are 95.5/3.8/0.7 Sn/Ag/Cu.
- 2. Backside surface is coated with a Ti/Ni/Ag layer.
- 3. Non-solder mask defined copper landing pad.
- 4. Laser marks on the silicon die back.
- 5. "b1" is the diameter of the solderable substrate surface, defined by an opening in the solder resist layer solder mask defined.
- 6. is the location of pin 1

DIM.	MILLIMETERS			INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.328	0.365	0.402	0.0129	0.0144	0.0158	
A1	0.136	0.160	0.184	0.0054	0.0063	0.0072	
A2	0.192	0.205	0.218	0.0076	0.0081	0.0086	
b	0.200	0.220	0.240	0.0079	0.0087	0.0094	
b1	0.175			0.0069			
е	0.400			0.0157			
S	0.160	0.180	0.200	0.0063	0.0071	0.0079	
D	1.920	1.960	2.000	0.0756	0.0772	0.0787	
E	2.320	2.360	2.400	0.0913	0.0929	0.0945	
K	0.040	0.070	0.100	0.0016	0.0028	0.0039	

#### Note

· Use millimeters as the primary measurement.

ECN: T15-0177-Rev. A, 27-Apr-15 DWG: 6040



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Revision: 13-Jun-16 1 Document Number: 91000

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